

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of:

Attorney Docket No.: 2267.841US03

Charles W. Extrand

Confirmation No.: 2262

Application No.: 10/662,979

Examiner: Robert W. Hodge

Filed: September 15, 2003

Group Art Unit: 1745

For: FUEL CELL WITH ULTRAPHOBIC SURFACES

INFORMATION DISCLOSURE STATEMENT

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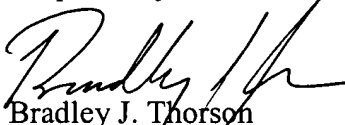
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Pursuant to 37 C.F.R. § 1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached Form PTO-1449. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

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This application was filed after June 30, 2003; therefore, copies of cited U.S. patents and U.S. published applications are not included.

Respectfully submitted,


Bradley J. Thorson
Registration No. 52,288

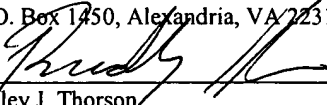
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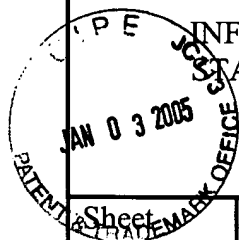
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**INFORMATION DISCLOSURE
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Complete if Known

Application Number	10/662,979
Filing Date	September 15, 2003
First Named Inventor	Charles W. Extrand
Art Unit	2262
Examiner Name	Robert W. Hodge
Attorney Docket Number	2267.841US03

Sheet 1 of 7

U.S. PATENT DOCUMENTS

EXAMINER INITIAL*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		Number-Kind Code ² (if known)		
		US-6,783,882 B2	08/31/2004	Jeffrey A. Schmidt
		US-6,660,363 B1	12/09/2003	Wilhelm Barthlott
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FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	T ⁶
		Country Code ³ Number ⁴ Kind Code ⁵ (if known)			
		WO 02/084340 A1	10/24/2002	Ming-Hsien Wu et al.	
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EXAMINER INITIAL*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published			T ²
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<p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. ¹Applicant's unique citation designation number (optional). ²Applicant is to place a check mark here if English language Translation is attached.</p> <p>This collection of information is required by 37 CFR 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 120 minutes to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, Washington, DC 20231. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, P.O. Box 1450 Alexandria, VA 22313-1450.</p>					

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		WILL H. COGHILL et al., <u>Why Water Over-Fills a Tumbler</u> , <i>Scientific American Supplement</i> , July 27, 1918, vol. 86, no. 2221, pp. 52-53	
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		BRIAN D. REISS et al., <u>DNA-Directed Assembly of Anisotropic Nanoparticles on Lithographically Defined Surfaces and in Solution</u> , <i>Materials Research Society</i> , 2001, vol. 635, pp.C6.2.1-C6.2.6			
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<p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. ¹Applicant's unique citation designation number (optional). ²Applicant is to place a check mark here if English language Translation is attached.</p> <p>This collection of information is required by 37 CFR 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 120 minutes to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, Washington, DC 20231. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, P.O. Box 1450 Alexandria, VA 22313-1450.</p> <p>If you need assistance in completing the form, call 1-800-PTO-9199 (1-800-786-9199) and select option 2.</p>					

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		R. SHUTTLEWORTH et al., <u>The Spreading of a Liquid Over a Rough Solid</u> , February 23, 1948, pp. 16-22			
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